



Premstaetten, April 30, 2021

CN22-2021 – Test Location for CMV12000 Mono PN Part and CMV12000 Color

Dear Customer,

Please be informed of the status of the test locations and platforms of the ams CMV12000 product family. ams AG will no longer proceed with the transfer of the wafer sort and final test of the Color variant and the final test of the Mono-PN variant to the Teradyne IP750EX ATE test platform, as summarized in the following overview.

Material Part Number	Material Description	Wafer Fabrication	Wafer Sort	Packaging	Device Test	Delivery	Summary
302000004	CMV12000-2E5C1PA QA	TowerJazz (Israel)	Proprietary Test System @ ams Sensors Belgium	Kanematsu Futuretech (Japan)	Proprietary Test System @ Kanematsu Futuretech (Japan)	ams (Belgium)	No change for the Color variant
302010005	CMV12000-2E5M1PN QA	TowerJazz (Israel)	Teradyne IP750EX @ KYEC (Taiwan)	Kanematsu Futuretech (Japan)	Proprietary Test System @ Kanematsu Futuretech (Japan)	ams (Belgium)	Change in wafer sort test platform only for the Mono-PN variant
302010004	CMV12000-2E5M1PA QA	TowerJazz (Israel)	Teradyne IP750EX @ KYEC (Taiwan)	Kanematsu Futuretech (Japan)	Teradyne IP750EX @ KYEC (Taiwan)	ams (Belgium)	Change in wafer sort and device test platform for Mono-PA variant

If you do have further questions, please do not hesitate to contact our customer support team at any time.

Best regards,

Peter Crabbe
ams AG
Director Operations CIS